Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/636,044	CHIU ET AL.	
Examiner	Art Unit	
Nicholas Augustina	2170	

SEARCHED					
Class	Subclass	Date	Examiner		
709	201-205	12/20/2007	NA		
709	214	12/20/2007	NA		
709	231-232	12/20/2007	NA		
715	863	12/20/2007	NA		
715	748	12/20/2007	NA		
715	751	12/20/2007	NA		
715	753	12/20/2007	NA		
715	761	12/20/2007	NA		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated Inventor name search	12/20/2007	NA		
Updated East Search: US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	12/20/2007	NA		
Updated NPL Search: IEEE XPlore; Google; Jux2; ACM; Proquest;Datastarweb	12/20/2007	NA		